



Key Features

- OTN, SDH, SONET in one instrument
- Optional DPSK modulation for OTN NE line side verification in the field
- 10/10.7G auxiliary port to interconnect STT 40G module with other 10G systems
- Fully independent or can be combined with other test modules to enhance application
- Internal SDH/SONET mapping down to VC12, VC11, VT1.5, VT2
- Complete performance tests and analysis for point to point links and DWDM networks
- Comprehensive SDH/SONET/OTN overhead control and decode
- Auto-configuration
- Stand-alone operation (no platform required) increases portability and flexibility
- Complies to ITU-T, Telcordia, and ANSI standards
- Intuitive user-friendly, yet powerful, Graphical User Interface

Benefits

- All-in-one transport networks test solution
- Cost-effective solution, as a stand-alone module, self-contained portable instrument, or as a 40/43G complement to existing STT ONE reducing CAPEX
- Eliminates the need for multiple platforms
- Same look and feel as other STT modules reduces the learning curve and operational expenditures
- Ideal for Network Element installation, verification and troubleshooting

The versatile and powerful STT 40G takes Sunrise Telecom's Scalable Test Toolkit (STT®) platform to a new level as a test and measurement solution for high speed transport networks such as 43G OTN (OTU3) and 40G SDH/SONET (STM-256/OC-768). With payload structure down to VC12, VC11, VT1.5, and VT2, it offers service providers a complete test solution for today's and tomorrow's Metro, Core, and DWDM transport networks. In addition to it, STT 40G now offers 43G DPSK modulation with tunable transmitter for OTN Network Element client and line side field verification. Its small size and weight in stand alone mode makes the STT 40G the smallest and lightest test set in the world. This commanding set of features is available in a single, compact, easy to use, and cost effective unit. The STT 40G can be used independently or combined with other test modules to enhance its application, taking advantage of its bidirectional 10.7/10G drop and insert port. Like other STT modules the STT 40G offers the revolutionary and cost-effective stand-alone mode in remote or local environments, allowing test modules to operate at 100% of their capabilities and features, even when removed from the STT platform.

- Increases availability of test gear as STT modules left behind can be used at 100% of their capabilities, while the test platform is being used in other application.
- Native Remote Control operation that can work on low bandwidth conditions, offering the most responsive system in the market.

The user-interface has been designed specifically for carrier, NEMs, and lab applications, maintaining the familiar look and feel of other STT products to reduce the learning curve and operational expenses. Auto configuration takes the guess-work out of configuring the instrument to the circuit being tested. Yet, experienced users will appreciate advanced features like overhead monitoring and control, APS timing measurement, pointer test sequences, and propagation delay measurement.

Test Features

With its comprehensive set of test and measurement features, the STT 40G allows the user to perform routine and advanced testing on high speed transport networks with a single platform.

All measurements conform to industry standards, and circuit impairments are displayed on a correlated graphical view, giving operators insight into the possible causes of circuit impairments. By combining the STT 40G with STT ONE, it offers a cost effective solution for testing all transport networks from 1.5 or 2 Mbit/s up to 40/43 Gbit/s, eliminating the need for multiple platforms.

Optical Transport Network (OTN)

STT 40G provides Forward Error Correction (FEC), verifies conformance to ITU-T G.709 and a wide range of network performance standards, including end-to-end connectivity at OTU3 bit rate, and complete synchronous/asynchronous mapping of SDH STM-256, SONET OC-768 client signals.

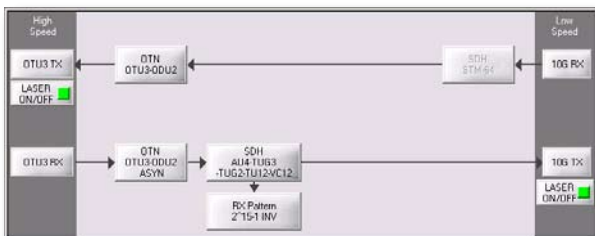
- OTU3 (43 Gbit/s) interface
- ODU Time Division Multiplexing (ODU2 into OPU3)
- Synchronous/asynchronous mapping of SDH/SONET signals
- OTN/SDH, OTN/SONET mux test and emulation
- Error performance analysis per ITU-T G.8201 and M.2401
- APS timing measurement
- Alarm Generation and Error Injection (including correctable and non-correctable FEC)
- OTN Tandem Connection Monitoring
- OTU, ODU, OPU error injection and alarm generation
- OTU, ODU, and OPU bytes control and decode
- Complies to ITU-T G.709

Traditional SDH/SONET

- Mapping/demapping of payloads from VC4-64c/STS-192c down to VC11, VC12/V T1.5, VT2
- SDH/SONET errors/alarms detection and generation
- SDH/SONET overhead control and decode
- Pointer monitoring and adjustment
- APS timing measurement
- Alarm Generation and Error Injection
- Complies to ITU, Telcordia, and ANSI standards

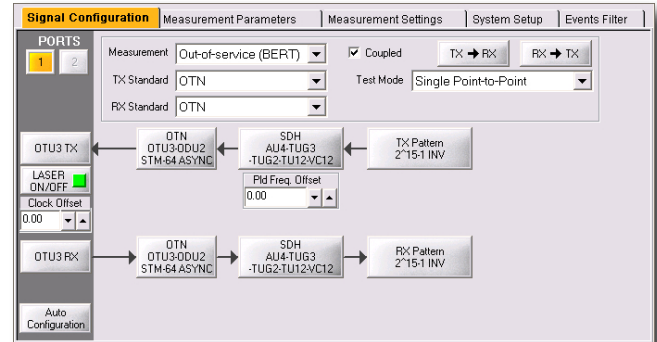
10/10.7G Auxiliary Port

- Field replaceable transceivers (XFP)
- OTU3 to OTU2 drop/insert
- OTU3 to STM-64 or OC-192 drop/insert
- STM-256 to STM-64 drop/insert
- OC-768 to OC-192 drop/insert



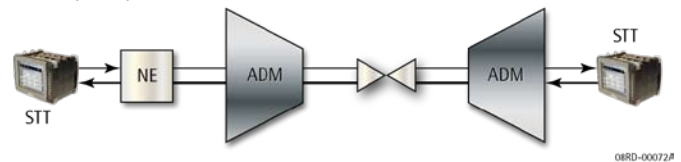
Applications

STT 40G allows the user to perform testing on high-speed transport networks. Offering both in-service and out-of-service configurations, the STT 40G covers installation, commissioning, maintenance and troubleshooting applications. Among other advance features, it supports a comprehensive set of test modes including point-to-point, through modes, mux-test and mux emulation. Its complete error insertion and alarm generation selection can be used to verify network performance monitoring systems. Application oriented graphical user interface shows the building blocks and flow of the test signals as user friendly set up guide.



Out-of-Service Testing

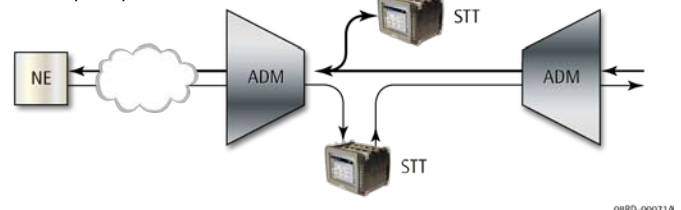
OTN/SDH/SONET



- Bring-into-service, stress testing, and maintenance
- Error performance analysis conforming to ITU-T and Telcordia recommendations
- End-to-end error free transmission verification
- SDH/SONET network routing verification

In-Service Testing

OTN/SDH/SONET



- Line and payload through mode monitoring
- In-service monitoring through protected monitoring points or optical splitters
- Overhead bytes monitoring and decoding
- Pointer monitoring

Mux Test

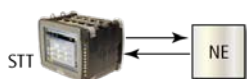


OTN

- OTN/SDH, OTN/SONET Mux/demux testing
- Asynchronous and synchronous mapping of SDH/SONET client signals into OTU3

Network Element Verification

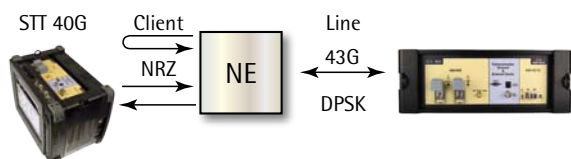
OTN/SDH/SONET



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- Error injection, alarm generation to verify NE remote indication
- FEC error generation to verify NE Forward Error Correction capabilities
- SDH/SONET Pointer Test Sequences generation to test NE response to problems with sync
- Frequency offset to stress clock recovery of NE
- ODU Time Division Multiplexing test

DPSK NE Field Installation/Verification



- DPSK line coding verification
- Tunable DPSK transmitter for DWDM C-band verification
- End to loopback client-to-line or line-to-client verification
- Bi-directional client-to-line and line-to client verification with 2 test sets
- OTN protocol verification

About STT Platform

The Scalable Test Toolkit (STT) is an advanced, modular, and flexible testing solution that addresses Layer 1 through Layer 7 requirements, from fiber optics to Quality of Service. Designed to meet the challenges of designing, installing, maintaining, and troubleshooting core, metro, and access networks, the STT combines an innovative test platform with revolutionary test features, supporting a complete suite of capabilities and technologies for the converging global communications market.

All STT modules are equipped with a unique standalone feature that allows them to operate at 100% of their capabilities outside of the platform, maximizing test resources.

- **STT ONE.** OTN, EoS (Ethernet over SDH/SONET), NGN (VCAT, LCAS and GFP), legacy SDH/SONET and PDH/T-carrier testing. Transport testing from 1.5/2 Mbit/s up to 10/10.7 Gbit/s. Advanced next generation network testing, GigE frames drop/insert from SDH/SONET via GFP-T port, Packet Capture and export, In-service real time monitoring of SDH/SONET tributaries (Channel Master), APS testing. Legacy networks testing: VF, Pulse Mask.
- **STT Metro.** 10/100/1000M Ethernet testing. Throughput and Bit Error testing across Layers 1, 2, and 3. Stacked VLAN (Q-in-Q) and MPLS. RFC 2544 benchmark testing. GPS antenna port for one-way latency measurements. IP connectivity testing. Bidirectional monitoring of live networks. Packet capture with decoding up to Layer 7.
- **STT 10G Ethernet.** 10 GigE LAN/WAN Ethernet testing. Throughput and Bit Error testing across Layers 1, 2, and 3. Advanced test features Stacked VLAN (Q-in-Q) and MPLS. RFC 2544 benchmark testing and packet capture and decode up to Layer 7.

Specifications

TEST INTERFACES

SDH and SONET

43/40G Optical Test Port

Port/Connector

Universal interface with FC-PC and SC-PC adapters

40/43G NRZ (STT-8100/STT-8110)

Transmitter

Line coding: NRZ

Single Mode 1550 nm

Output power range

1550 nm, 2 km: 0 to +3 dBm

Laser Safety: Class 1, IEC 60825-1, FDA/CDRH, 21 CFR 1040.10 and 1040.11

Bit rates

43.018413 Gbit/s ± 4.6 ppm (OTU3)

39.81312 Gbit/s ± 4.6 ppm (STM-256, OC-768)

Clock source

Internal

Freq. offset: ± 50 ppm with 1, 0.1 ppm resolution

Received

Recovered from received signal

External

2.048 Mbit/s (MTS/SETS) or 2.048 MHz (SDH)

1.544 Mbit/s (BITS) or 1.544 MHz (SONET)

64K+8K co-directional

Complies to ITU-T G.709, G.693 VSR2000-3R2

Receiver

Frequency recovery range

43.018413 Gbit/s ± 50 ppm (OTU3)

39.81312 Gbit/s ± 50 ppm (STM-256, OC-768)

Jitter tolerance

ITU-T G.825, G.783

GR-253-CORE

Operational wavelength range

1290 to 1565 nm

Receiver sensitivity is specified and guaranteed at 1550 nm

Input power range

1550 nm Short Reach, PIN detector: -6 to +3 dBm

Damage level: +7 dBm (peak)

Complies to ITU-T G.709, G.693 VSR200-3R2, and G.8251

43G DPSK (STT-8120/STT-8130)

Transmitter

Line coding: NRZ-DPSK

Single Mode

Adjustable wavelength range

1528.77 – 1563.45 nm

Frequency grid:

50 GHz per ITU-T G.694.1

Output power

+3 dBm

Bit rates

43.018413 Gbit/s ± 4.6 ppm (OTU3)

Clock source

Internal

Freq. offset: ± 50 ppm with 1, 0.1 ppm resolution

Received

Recovered from received signal

External

2.048 Mbit/s (MTS/SETS) or 2.048 MHz (SDH)

1.544 Mbit/s (BITS) or 1.544 MHz (SONET)

64K+8K co-directional

Complies to ITU-T G.709

Receiver

Frequency recovery range

43.018413 Gbit/s ± 50 ppm (OTU3)

Operational wavelength range

1528.77 – 1563.45 nm

Receiver sensitivity is specified and guaranteed

Input power range

+2 to +10 dBm

Damage level: +13 dBm (peak)

10.7/10G Auxiliary Port (STT-8110 /8130 Only)

Uses field replaceable XFP transceiver modules

Port/Connector: LC-PC

Transmitter

Line coding: NRZ

Single Mode Optics

Bit rates

10.70923 Gbit/s ± 4.6 ppm (OTU2)

9.96328 Gbit/s ± 4.6 ppm (STM-64, OC-192)

Clock source

Internal

Recovered from 43/40G signal

Receiver

Frequency recovery range

10.70923 Gbit/s ± 100 ppm (OTU2)

9.96328 Gbit/s ± 100 ppm (STM-64, OC-192)

Complies to ITU-T G.709 and G.959.1

SA586-1550MR XFP: 10G Multirate transceiver (optional)

Output power range

1550 nm: -1 to +2 dBm

Laser Safety: Class 1, IEC 60825-1, FDA/CDRH, 21 CFR 1040.10 and 1040.11

Input power range

Intermediate Reach, PIN detector: -14 to 0 dBm

Saturation level: -1 dBm

Operational wavelength range

1260 to 1565 nm

Communication Channel and Clocks

DCC/GCC

Micro D-sub 9-pin

DCC (D1-D3, D4-D12), GCC0, GCC1, or GCC2 Drop and Insert port

External Clock Inputs

BNC, 75 Ohms unbalanced

2 Mbit/s and 2 MHz

Bantam, 100 Ohms balanced

1.5 Mbit/s and 1.5 MHz

Bantam, 110 Ohms balanced

64 Kbits

Reference Clock Output

Connector: SMA, 50 Ohms unbalanced

Signal: 200~450mV

Frequency

43G: 2.7 GHz

40G: 2.5 GHz



TEST FEATURES

Application Modes

Standards

OTN, SDH, SONET, and Unframed (43/40G)

*Unframed mode supports PRBS test patterns only

Measurement Modes

Out-of-service (BERT) and In-service (Live)

Tx and Rx Configuration

Coupled: Tx and Rx are coupled together and have the same configuration

Independent: Tx and Rx may be configured independently

TEST MODES

Point-to-point

Tx and Rx are set to the same rate

Internal mapping and multiplexing down to 2 and 1.5 Mbit/s tributaries

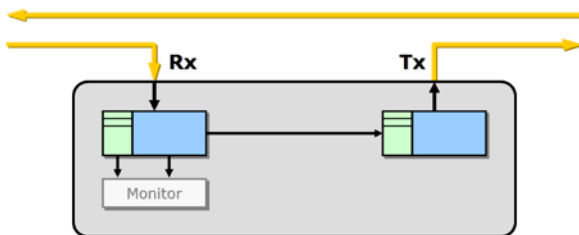
Through Mode Operation

Line through

Monitors the entire signal as it passes through the instrument with no manipulation of overhead, errors, or alarms

Overhead can be monitored

Alarms and errors are measured

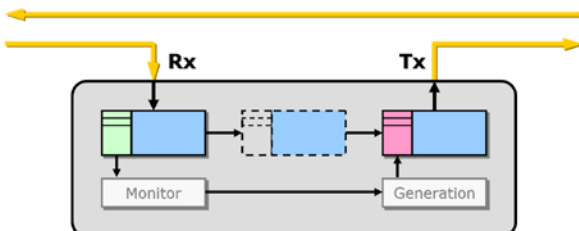


Payload through

Passes the payload (including POH) through the instrument with overhead manipulation

SOH (SDH/SONET) and OTU/ODU (OTN) error insertion and alarm generation

SOH (SDH/SONET) and OTU/ODU (OTN) overhead control (except pointers)



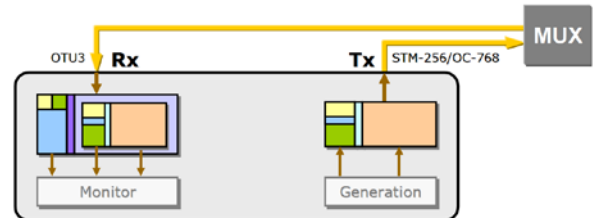
Mux/Demux Test (40G/43G)

Mux test

Test pattern is generated on 40G SDH/SONET Tx and the BER test is performed on the 43G OTN Rx

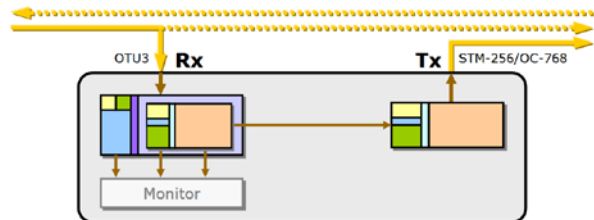
Demux test

Test pattern is generated on 43G OTN Tx and the BER test is performed on the 40G SDH/SONET Rx



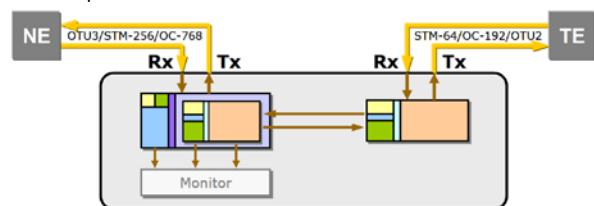
Mux/Demux Mode (40G/43G)

Drop or insert an external 40G SDH/SONET signal from/to 43G OTN Unidirectional



10/10.7G Drop and Insert (STT-8110 Only)

Uses the Auxiliary 10/10.7G port for bidirectional STM-64/OC-192 or OTU2 payload drop and insert from STM-256/OC-768 or OTU3 signals to an STT ONE or another external test equipment, analyzer, simulator, or network element.

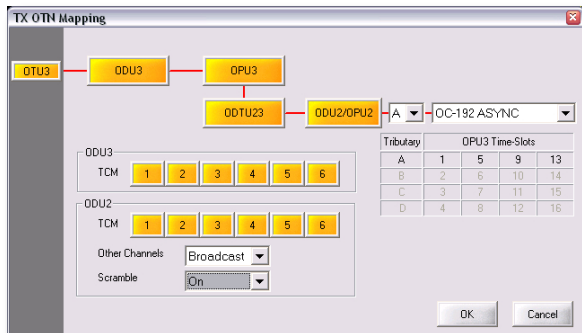


OTN Tests and Measurements

Frame/Payloads

Frame and mapping structure conforms to ITU-T G.709

Synchronous and asynchronous mapping of SDH/SONET payloads and PRBS test signals



OTU Time Division Multiplexing Mappings

ODU2 into OPU3 (internal and external)

Flexible channel numbering:

- Standard (G.709)
- User selectable OPU3 timeslots (4 out of 16)

External mapping (drop/insert or digital wrapper emulation mode)

Selectable measurement side (high or low)

OPU2 payloads

STM-64 synchronous and asynchronous

OC-192 synchronous and asynchronous,

Bulk Mode.

SONET/SDH payload mapping down to VC12, VC11 / VT1.5,

VT2 bulk modes

OPU2 payload scrambling

Programmable payload frequency offset

Test Patterns

Framed mode

PRBS: $2^{31}-1$, $2^{23}-1$, $2^{20}-1$, $2^{15}-1$

Fixed: all 1s, all 0s, alt 1010, 1-4

User: 10 programmable 16-bit user patterns. Pattern names up to 10 characters.

Unframed mode

PRBS: $2^{31}-1$, $2^{23}-1$, $2^{20}-1$, $2^{15}-1$

Test pattern inversion

Error Injection

OTU: FAS (OA1, OA2), MFAS, SM-BIP-8, SM-BEI, correctable FEC errors, uncorrectable FEC errors

ODU: PM-BIP-8, PM-BEI

TCM1-6: BIP-8, BEI

Payload bit errors

Modes

Single

Burst: 1 to 8000

Rate: 1×10^{-9} to 2×10^{-3}

(Options vary depending on configuration and error type)

Alarm Generation

OTU: LOS, LOF, OOF, OOM, AIS, SM-TIM, SM-IAE, SM-BDI, SM-BIAE,

ODU: AIS, OCI, LCK, BDI, PM-TIM, PM-BDI

TCM1-6: OCI, AIS, LCK, TIM, BDI, IAE, LTC, SM-BDI, SM-BIAE

Modes

Single

Periodic (number of frames ON and OFF)

Continuous

(Options vary depending on configuration and alarm type)

Measurements

Errors

OTU: FAS (OA1, OA2), MFAS, SM-BIP-8, SM-BEI, SM-BDI, SM-BIAE, correctable FEC errors, uncorrectable FEC errors

ODU: PM-BIP-8, PM-BEI

TCM1-6: BIP-8, BEI

Payload bit errors

Alarms

OTU: LOS, LOF, OOF, OOM, AIS, SM-TIM, SM-IAE, SM-BDI, SM-BIAE

ODU: AIS, OCI, LCK, BDI, PM-TIM, PM-BDI

OPU: PLM

TCM1-6: OCI, AIS, LCK, TIM, BDI, IAE, LTC, SM-BDI, SM-BIAE

Error performance analysis: ITU-T G.8201, M.2401

Overhead Features

FAS						MFAS	SM			GCC0		RES		RES	JC		
OA1 F6	OA1 F6	OA1 F6	OA2 28	OA2 28	OA2 28	XX	TTI 00	BIP8 XX	BEI 00	00	00	00	00	00	XX		
RES			TCM ACT	TCM6			TCM5			TCM4			FTFL		RES	JC	
00	00	00	00	TTI 00	BIP8 XX	BEI 01	TTI 00	BIP8 XX	BEI 01	TTI 00	BIP8 XX	BEI 01	00	00	XX		
TCM3			TCM2			TCM1			PM			EXP		RES	JC		
TTI 00	BIP8 XX	BEI 01	TTI 00	BIP8 XX	BEI 01	TTI 00	BIP8 XX	BEI 01	TTI 00	BIP8 XX	BEI 01	RR 00	RR 00	00	XX		
GCC1		GCC2		APS/PCC				RES								PSI	ILJO
00	00	00	00	00	00	00	00	00	00	00	00	00	00	20	00		
OTU OH			ODU OH			OPU OH			Sequence Set Default Edit								

Overhead Monitor

Hex display of all bytes (OTU, ODU, and OPU)

Text decode of all applicable bytes

TTI [SM (OTU), PM (ODU), TCM1-6], FTFL, APS/PCC, PSI

Conforms to ITU-T G.709

Overhead Programming

Hex input for all bytes except framing (FAS and MFAS), parity (BIP8, BEI) and justification (JC)

Trail Trace Identifier (TTI) Generation

SM (OTU), PM (ODU), TCM1-6: SAPI/DAPI 16 bytes E.164

ASCII sequence

Operation bytes: 32 bytes HEX or E.164 ASCII sequence

Automatic Protection Switching (APS)/Protection Communication

Channel (PCC) bytes control & decode per ITU-T G.709 and G.873

Fault Type Fault Locator (FTFL) control and decode. Forward and backward field structure per ITU-T G.709

Payload Structure Identifier

Payload type generation/decode: Hex mode or text mode

Conforms to ITU-T G.709, PT decode requires locking to MF #1

Overhead Sequence Generation

Bytes: TTI (SM, PM, TCM1-6), GCC0, GCC1, GCC2, APS/PCC, or any single overhead byte

Generates up to 256 elements

Overhead Sequence Capture

OA1/OA2, TTI (SM, PM, TCM1-6), GCC0, GCC1, GCC2, APS/PCC, or any single overhead byte

Captures up to 256 elements

Automatic Protection Switch Time Measurement

Resolution: 1 ms

Accuracy: $\pm 3.035 \mu s$

Sensors: LOS, LOF, LOM, OTU-AIS, OTU-IAE, OTU-BIAE, OTU-BDI, ODU-AIS, ODU-OCI, ODU-LCK, ODU-BDI, OPU-PLM

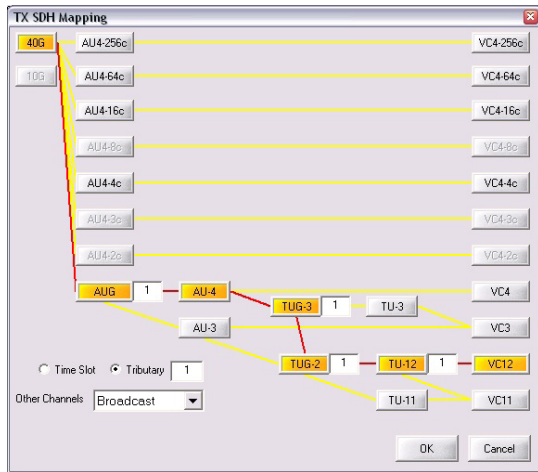
Pass/Fail indication

Programmable switch time and gate time

SDH

Payloads

VC4-256c Bulk, VC4-64c Bulk, VC4-16c Bulk, VC4-4c Bulk, VC4 Bulk,
VC3 Bulk, VC12 Bulk, VC11 Bulk



Test Patterns

Framed mode

PRBS: $2^{31}-1$, $2^{23}-1$, $2^{20}-1$, $2^{15}-1$, $2^{11}-1$, 2^9-1

Fixed: All 1s, All 0s, Alt 1010, 1-4

User: 10 programmable 16-bit user patterns. Pattern names up to 10 characters.

Unframed mode

PRBS: $2^{31}-1$, $2^{23}-1$, $2^{20}-1$, $2^{15}-1$

Test pattern inversion

Error Injection

Bit, FAS (Frame base), B1, B2, B3, LP-BIP, MS-REI, HP-REI, LP-REI

Modes

Single

Burst: 1 to 8000

Rate: 1×10^{-9} to 2×10^{-3}

(Options vary depending on configuration and alarm type)

Alarm Generation

RS: LOS, LOF, RS-TIM

MS: MS-AIS, MS-RDI

AU: AU-LOP, AU-AIS

HP: HP-AIS, HP-UNEQ, HP-TIM, HP-RDI, HP-PLM, HP-ERDI (Payload, Server, Connectivity)

TU: TU-LOP, TU-AIS, TU-LOM

LP: LP-UNEQ, LP-TIM, LP-RDI, LP-PLM, LP-ERDI (Payload, Server, Connectivity)

Modes

Single

Periodic (number of frames ON and OFF)

Continuous

(Options vary depending on configuration and alarm type)

Measurements

Errors

FAS (# of Frame errors per Frame), Bit, B1, B2, B3, BIP-2, MS REI, HP/LP REI

Alarms

RS: LOS, LOF, OOF, RS-TIM

MS: MS-AIS, MS-RDI

AU: AU-AIS, AU-LOP

HP: HP-AIS, HP-PLM, HP-ERDI (Payload, Server, Connectivity), HP-TIM, HP-UNEQ

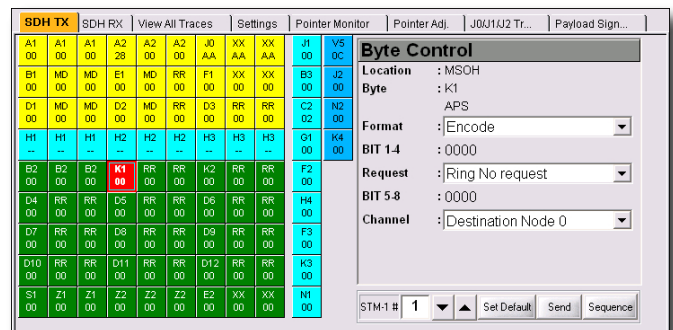
TU: TU-LOM, TU AIS, TU-LOP

LP: LP-PLM, LP-ERDI (Payload, Server, Connectivity), LP-TIM, LP-UNEQ

Error performance analysis

ITU-T G.821, G.826, G.828, G.829, M.2101, M.2110, M.2120

Overhead Features



Overhead Sequence Capture

Capture: J0/J1/J2, K1/K2 (2 bytes), or any single overhead byte
Each new value is captured with a timestamp (absolute or elapsed) and duration (in ms or frames)
Trigger: Manual or user-defined value
Resolution: 125 μ s (1 frame)
Captures up to 256 elements

Trace Generation

J0 Section trace: 1 byte, 16 bytes, E.164/ASCII sequence + CRC-7 or 64 bytes E.164/ASCII sequence
J1/J2 Path trace: 16 bytes E.164/ASCII sequence + CRC-7 or 64 bytes E.164/ASCII sequence
Selection: Default, user, or through

Pointer Monitor

Instantaneous pointer value display
Loss of pointer seconds
Total justification count
Positive justification count
Negative justification count
New Data Flag (NDF) seconds

Pointer Adjustment

Programming of STS and VT pointer values, NDF, and SS bits
Pointer increase or decrease

Pointer Test Sequences

Standard: ANSI T1.105.03, Telcordia GR-253
Sequences: Single, burst, phase transient burst, periodic, 87-3, 26-1, opposite, and custom
Movement: Increase, decrease, increase + decrease
Anomalies: Added, cancel, and none
Frequency offset: Positive, negative, and none
Sequence timing: Initialization, cool down, and measurement

Automatic Protection Switch Time Measurement

Resolution: 1 millisecond
Sensors: LOS, LOF, AIS-L, AIS-V, RDI-L, AIS-P, REI-L, RDI-P, RDI-V,
Pass/Fail indication
Programmable switch time and gate time

Common to OTN, SDH and SONET

Measurements

Optical power level measurement

Accuracy: ± 3 dB

Wavelength: 1550 nm

Receiver sensitivity and optical power measurement accuracy are specified and guaranteed at 1550 nm

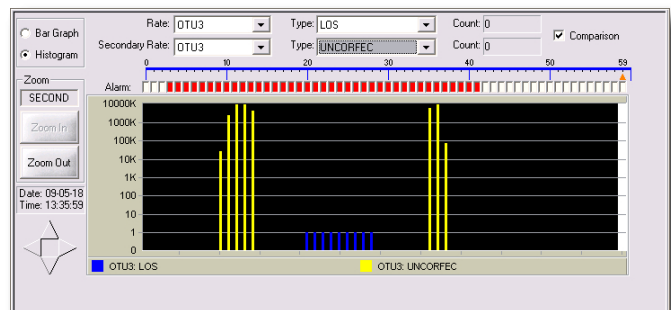
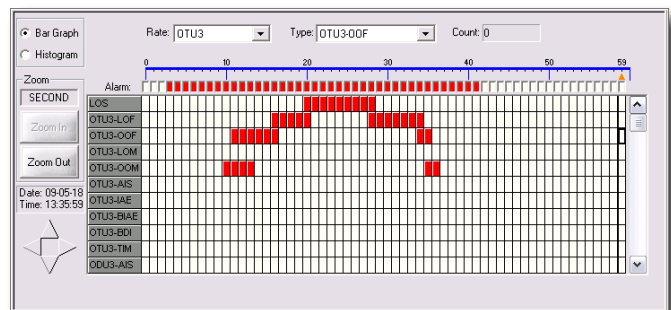
Optical saturation indication

Histogram analysis and bar graph correlation

Errors/Alarms/Pointer/Clock graphic display in real time

Stores current results with 1-second resolution for the last 12 hrs, 1-minute resolution for the last 72 hrs, and 15-minute resolution for the last 60 days

Compare two parameters to visually detect correlation



Frequency

Current, maximum, minimum frequency offset (ppm)

Events log with 100 ms time stamps

Tracks individual events, sequence and severity count

Full screen status

Detailed overview

Large color coded Alarm/Error

Service disruption measurement

Programmable error-free test window: 1-3000ms

Minimum disruption time: 50 μ s

Minimum defect time: 50 μ s

Longest, shortest, last and total counters

Available for PRBS only

Measurement Settings

- Continuous measurement
- Programmable start time and duration
- Elapsed time, remaining time display
- Auto-configuration (40/43G Only)
 - Automatically determines rate framing, payload structure, and test pattern
 - Configures Tx to match the received signal
 - Save, view, and reload configuration profiles

Measurement Results Management

- Open
 - Opens previously saved or archived measurement results
- Print
 - Prints measurement results
- Export
 - Export measurement results reports file to comma separated values (which can be read by text editors, word processors, or spreadsheet program), XML or text formats
 - Test records can be exported to hard drive or USB memory
- Archive
 - Moves test records to the hard drive in raw format
 - Test records can be opened in other instruments or PCs to be analyzed in its native format (require the STT 40G software)
 - Archive All option
- Test records
 - View
 - Lock and Unlock
 - Delete and Delete All
 - Rename
- STT Reporter
 - Generates PDF reports with user-customizable headers, contact information, logo, case information, and comments

GENERAL

Instrument Mode

Self-contained portable instrument, using attached STT Controller and power supply



Stand-alone Mode

Remote or local operation using a networked PC or direct Ethernet connection

Requires SA427 stand-alone kit

Automatic discovery of all test modules in the same network

Multiple units within the same network can be controlled from one PC

Offers 100% of its capabilities



Software upgrades via USB memory or LAN (through STT Controller or PC)

TL1 commands for remote operation and test automation

Admin Serial Port

Built-in DB-9 for service, diagnostics, and TL1

Ethernet Port

Built-in RJ-45, 10/100BaseT for service, diagnostics, TL1, and remote operation

Power requirements

Consumption: 110 watts (module only)

Power supplies

Compatible with STT-1525 and SA427; 100~240Vac, 50~60Hz (check with manufacturer for other options available)

Battery backup with STT-1525, for uninterrupted measurements

Environmental

CE Mark: Conforms to the applicable sections of 98/63/EEC

Operating temperature: 32 to 104°F (0 to 40°C)

Storage temperature: -4 to 158°F (-20 to 70°C)

Humidity: 5% to 85% non-condensing

Dimensions

Size: 12.6 x 8.7 x 4.4 in (320 x 220 x 110 mm)

Weight: 8.8 lbs (4.0 kg)

Ordering Information

Control Module

STT-1001 STT Control Module
[STT Control and Display Module with Windows XP Professional OS. Includes STT Manager Software (STT-1000-SW1), STT User's Manual. (SA920), Qty 2 Stylus (SA142), STT bus bridge case (SA144), Small Accessory Storage case (SA149). Requires STT Power Module and Test Module(s)]

Power Modules

STT-1501 Power Module, AC. 216 Watt maximum output

STT-1521 Power Module, AC. 340 Watt maximum output

STT-1525 Power Module, AC and Battery. 150 Watt maximum output

SA427 STT Stand-Alone Accessory Package. 130 Watt maximum output
[Includes: SA170 130 Watt external AC/DC Power Adapter; SA265 100 Ohm, CAT 5, RJ45 (m) to RJ45 (m), Cross-over 6' cable; SA266 Cable; 100 Ohm, CAT 5, RJ45 (m) to RJ45 (m), Straight 6' cable; SA144 STT Bus Case; 4x Screw-on feet]

SA155-UK 3-prong power cord for use in United Kingdom.

SA155-EU 2-Prong power cord plus ground for use in Europe (Except UK)

SA155-NA 3-prong power cord for use in Latin America, North America, and Asia

SA155-SW 3-prong power cord for use in Switzerland

SA155-SA 3-prong power cord for use in South Africa/India

10/10.7G XFP Optics Options for STT-8110

SA586-1550MR . XFP: 10G Multi-rate Transceiver
[1550 nm Single-mode, 40km, 9.95Gb/s to 10.7Gb/s transceiver plug-in for 10GBASE-ER/EW and FEC, 10G Fibre Channel, OC-192/STM-64 IR, OTU2. LC Connector.]

STT 40G Test Module

STT-8100 STT 40G Module
OTN/SDH/SONET 40/43G analysis at OTU3, STM-256, and OC-768. Offers 40/43G optical interface.
[Includes: 40/43G Single Wavelength, 1550 nm Short Reach Tx/Rx optical transceiver; Standard universal optical connector base with UPC termination; 2x SA527 FC adapter for Universal Optical connector; 2x SA528 SC adapter for Universal Optical connector; SA918 STT 40G Users' Manual CD-ROM, one-year standard warranty and Certificate of Calibration]

STT-8110 STT 40G Module with 10/10.7G port
OTN/SDH/SONET 40/43G analysis at OTU3, STM-256, and OC-768. Offers 40/43G optical interface and 10/10.7G auxiliary XFP port for external drop/insert applications.
[Includes: 40/43G Single Wavelength, 1550 nm Short Reach Tx/Rx optical transceiver; Standard universal optical connector base with UPC termination; 2x SA527 FC adapter for Universal Optical connector; 2x SA528 SC adapter for Universal Optical connector; SA918 STT 40G Users' Manual CD-ROM, one-year standard warranty and Certificate of Calibration. Requires optional XFP optical transceiver modules for 10/10.7G]

STT-8120 STT 40G Module 43G DPSK OTN 43G analysis at OTU3 with STM-256/OC-768 client signals. Offers 43G DPSK optical interface and tunable Tx.
[Includes: Standard universal optical connector base with UPC termination; 2x SA527 FC adapters for Universal Optical connector; 2x SA528 SC adapters for Universal Optical connector; SA919 STT 40G Users' Manual (SA919), one-year standard warranty and Certificate of Calibration]

STT-8130 STT 40G Module 43G DPSK OTN 43G analysis at OTU3 with STM-256/OC-768 client signals. Offers 43G DPSK optical interface, tunable Tx and 10/10.7G auxiliary XFP socket for Drop/Insert.
[Includes: Standard universal optical connector base with UPC termination; 2x SA527 FC adapters for Universal Optical connector; 2x SA528 SC adapters for Universal Optical connector; SA919 STT 40G Users' Manual (SA919), one-year standard warranty and Certificate of Calibration]

Warranty

SST-8100-W1 . . . STT 40G Model OTN/SDH/SONET40/43G,
Standard Warranty

STT-8100-EW1 . . . STT 40G, 1 Yr Extended Warranty

STT-8100-EW2 . . . STT 40G, 2 Yrs Extended Warranty

STT-8110-W1 . . . STT 40G Model w/10/10.75G,Port,
Standard Warranty

STT-8110-EW1 . . . STT 40G, 1 Yr Extended Warranty

STT-8110-EW2 . . . STT 40G, 2 Yrs Extended Warranty

STT-8120-W1 . . . STT 40G MODULE 43G DPSK,
Standard Warranty

STT-8120-EW1 . . . STT 40G, 1 Yr Extended Warranty

STT-8120-EW2 . . . STT 40G, 2 Yrs Extended Warranty

STT-8130-W1 . . . STT 40G MODULE 43G DPSK, with 10G PORT,
Standard Warranty

STT-8130-EW1 . . . STT 40G, 1 Yr Extended Warranty

STT-8130-EW2 . . . STT 40G, 2 Yrs Extended Warranty

Universal Connector Adapters

SA527 FC adapter for Universal Optical connector

SA528 SC adapter for Universal Optical connector

SA529 LC adapter for Universal Optical connector
[Check with factory for availability and lead time]

SA530 ST adapter for Universal Optical connector
[Check with factory for availability and lead time]

SA532 DIN adapter for Universal Optical connector
[Check with factory for availability and lead time]

Other Accessories

SA620 Semi-rigid Carrying Case with wheels and
telescoping handle

SA622 Hard Carrying Case with Wheels for STT

Replacement Parts

SA170 STT Power Supply for stand-alone mode.
130 Watt maximum output

SA918 STT 40G User's Manual CD-ROM

Important Notice:

This product may contain technologies regulated by U.S. export control law. In the case of the export of product(s) and/or technologies described in this document, please take the appropriate procedure in conforming to all regulations related to the export. ECCN 5B001.b.1 : Telecommunications & information security; test, inspection and production equipment.



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